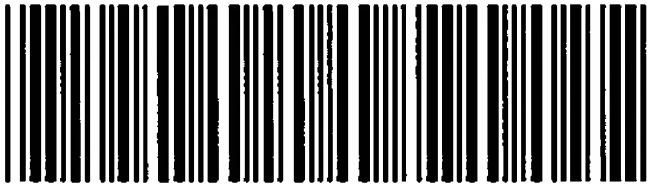


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/656,762	ZHANG, XIAOPIN	
	Examiner	Art Unit	
	David Mis	2817	

SEARCHED			
Class	Subclass	Date	Examiner
331	1A, 16-18, 23, 25	2/22/2005	DM
327	115,		
	117, 118,		
	156-159		
332	127		
360	51		
375	376		
455	260		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR